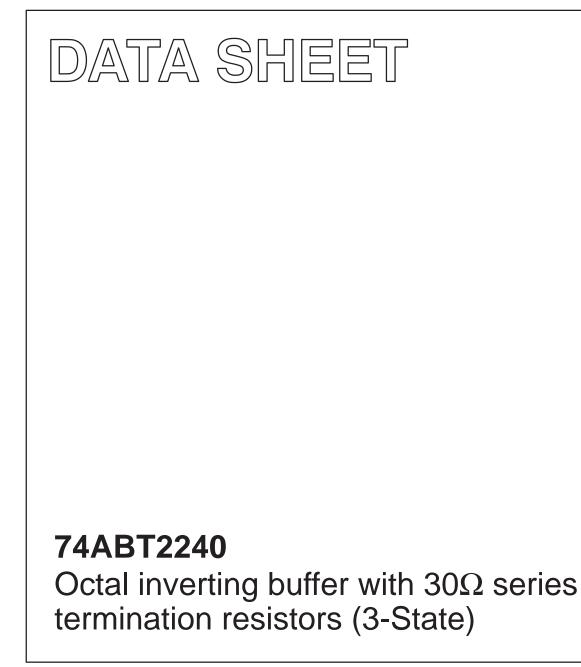
INTEGRATED CIRCUITS



Product specification Supersedes data of 1996 Oct 08 IC23 Data Handbook

1998 Jan 16



74ABT2240

FEATURES

- Octal bus interface
- 3-State buffers
- Live insertion/extraction permitted
- Outputs include series resistance of 30Ω, making external termination resistors unnecessary
- Output capability: +12mA/-32mA
- Latch-up protection exceeds 500mA per Jedec Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model
- Power-up 3-State
- Same part as 74ABT240-1

QUICK REFERENCE DATA

DESCRIPTION

The 74ABT2240 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed.

The 74ABT2240 device is an octal inverting buffer that is ideal for driving bus lines. The device features two Output Enables ($1\overline{OE}$, $2\overline{OE}$), each controlling four of the 3-State outputs.

The 74ABT2240 is designed with 30Ω series resistance in both the High and Low states of the output. This design reduces line noise in applications such as memory address drivers, clock drivers and bus receivers/transmitters.

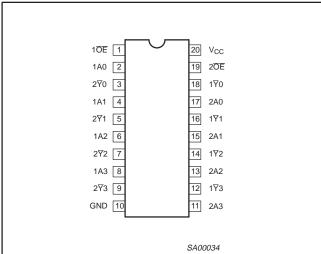
The 74ABT2240 is the same as the 74ABT240-1. The part number has been changed to reflect industry standards.

SYMBOL	PARAMETER	TYPICAL	UNIT	
t _{PLH} t _{PHL}	Propagation delay An to Yn	C _L = 50pF; V _{CC} = 5V	2.8 4.3	ns
C _{IN}	Input capacitance	$V_I = 0V \text{ or } V_{CC}$	3	pF
C _{OUT}	Output capacitance	Outputs disabled; $V_0 = 0V$ or V_{CC}	7	pF
I _{CCZ}	Total supply current	Outputs disabled; $V_{CC} = 5.5V$	50	μA

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
20-Pin Plastic DIP	–40°C to +85°C	74ABT2240 N	74ABT2240 N	SOT146-1
20-Pin plastic SO	–40°C to +85°C	74ABT2240 D	74ABT2240 D	SOT163-1
20-Pin Plastic SSOP Type II	–40°C to +85°C	74ABT2240 DB	74ABT2240 DB	SOT339-1
20-Pin Plastic TSSOP Type I	–40°C to +85°C	74ABT2240 PW	7ABT2240PW DH	SOT360-1

PIN CONFIGURATION

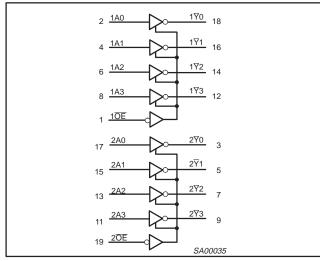


PIN DESCRIPTION

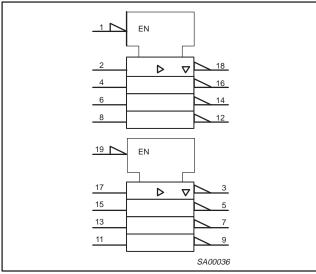
PIN NUMBER	SYMBOL	NAME AND FUNCTION
2, 4, 6, 8	1A0 – 1A3	Data inputs
11, 13, 15, 17	2A0 – 2A3	Data inputs
18, 16, 14, 12	$1\overline{Y}0 - 1\overline{Y}3$	Data outputs
9, 7, 5, 3	2 <u>7</u> 0 – 2 <u>7</u> 3	Data outputs
1, 19	1 <u>0E</u> , 2 <u>0E</u>	Output enables
10	GND	Ground (0V)
20	V _{CC}	Positive supply voltage

74ABT2240

LOGIC SYMBOL



LOGIC SYMBOL (IEE/IEC)



FUNCTION TABLE

	INP	OUTF	PUTS		
10E	1An	2 <mark>0E</mark>	2An	1 Y n	2 ∀ n
L	L	L	L	Н	Н
L	Н	L	Н	L	L
н	Х	Н	Х	Z	Z

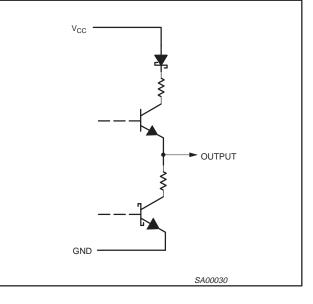
H = High voltage level

L = Low voltage level

X = Don't care

Z = High impedance "off" state

SCHEMATIC OF EACH OUTPUT



ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +7.0	V
I _{IK}	DC input diode current	V ₁ < 0	-18	mA
VI	DC input voltage ³		-1.2 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	output in Off or High state	–0.5 to +5.5	V
I _{OUT}	DC output current	output in Low state	128	mA
T _{stg}	Storage temperature range		-65 to 150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
The input and output voltage rating may be exceeded if the input and output current ratings are observed.

3. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

74ABT2240

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIM	UNIT	
STWBOL	FARAIVIETER	Min	Max	UNIT
V _{CC}	DC supply voltage	4.5	5.5	V
VI	Input voltage	0	V _{CC}	V
V _{IH}	High-level input voltage	2.0		V
V _{IL}	Low-level Input voltage		0.8	V
I _{ОН}	High-level output current		-32	mA
I _{OL}	Low-level output current		12	mA
Δt/Δv	Input transition rise or fall rate	0	10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

DC ELECTRICAL CHARACTERISTICS

					LIMITS			
SYMBOL	PARAMETER	IETER TEST CONDITIONS T _{amb} = +25°						UNIT
			Min	Тур	Max	Min	Max	1
V _{IK}	Input clamp voltage	$V_{CC} = 4.5V; I_{IK} = -18mA$		-0.9	-1.2		-1.2	V
		V_{CC} = 4.5V; I_{OH} = -3mA; V_I = V_{IL} or V_{IH}	2.5	2.9		2.5		V
V _{OH}	High-level output voltage	V_{CC} = 5.0V; I_{OH} = -3mA; V_I = V_{IL} or V_{IH}	3.0	3.4		3.0		V
		V_{CC} = 4.5V; I_{OH} = -32mA; V_{I} = V_{IL} or V_{IH}	2.0	2.4		2.0		V
V _{OL}	Low-level output voltage	V_{CC} = 4.5V; I_{OL} = 5mA; V_I = V_{IL} or V_{IH} ;		0.32	0.55		0.55	V
		V_{CC} = 4.5V; I_{OL} = 12mA; V_I = V_{IL} or V_{IH}			0.8		0.8	V
l _l	Input leakage current	V _{CC} = 5.5V; V _I = GND or 5.5V		±0.01	±1.0		±1.0	μA
I _{OFF}	Power-off leakage current	V_{CC} = 0.0V; V_O or $V_I \leq 4.5V$		±5.0	±100		±100	μA
I _{PU/PD}	Power–up/down 3-State output current ³	$V_{CC} = 2.1V; V_O = 0.5V; V_I = GND \text{ or } V_{CC};$ V _{OE} = Don't care		±5.0	±50		±50	μA
I _{OZH}	3-State output High current	V_{CC} = 5.5V; V_{O} = 2.7V; V_{I} = V_{IL} or V_{IH}		0.01	50		50	μΑ
I _{OZL}	3-State output Low current	V_{CC} = 5.5V; V_{O} = 0.5V; V_{I} = V_{IL} or V_{IH}		-0.01	-50		-50	μA
I _{CEX}	Output high leakage current	V_{CC} = 5.5V; V_{O} = 5.5V; V_{I} = GND or V_{CC}		5.0	50		50	μA
Ι _Ο	Output current ¹	$V_{CC} = 5.5V; V_{O} = 2.5V$	-50	-100	-180	-50	-180	mA
I _{CCH}		V_{CC} = 5.5V; Outputs High, V_{I} = GND or V_{CC}		50	250		250	μA
I _{CCL}	Quiescent supply current	V_{CC} = 5.5V; Outputs Low, V_I = GND or V_{CC}		24	30		30	mA
I _{CCZ}		V_{CC} = 5.5V; Outputs 3-State; V _I = GND or V _{CC}		50	250		250	μA
		Outputs enabled, one data input at 3.4V, other inputs at V_{CC} or GND; $V_{CC} = 5.5V$		0.5	1.5		1.5	mA
ΔI_{CC}	Additional supply current per input pin ²	Outputs 3-State, one data input at 3.4V, other inputs at V_{CC} or GND; $V_{CC} = 5.5V$		50	250		250	μA
		Outputs 3-State, one enable input at 3.4V, other inputs at V_{CC} or GND; $V_{CC} = 5.5V$		0.5	1.5		1.5	mA

NOTES:

1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
This is the increase in supply current for each input at 3.4V.
This parameter is valid for any V_{CC} between 0V and 2.1V, with a transition time of up to 10msec. From V_{CC} = 2.1V to V_{CC} = 5V ± 10% a transition time of up to 100µsec is permitted.

Product specification

74ABT2240

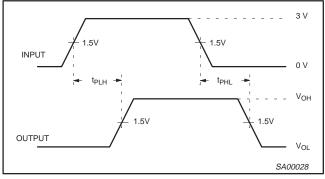
AC CHARACTERISTICS

GND = 0V; $t_R = t_F = 2.5 \text{ns}$; $C_L = 50 \text{pF}$, $R_L = 500 \Omega$

					LIMI	rs		
SYMBOL	PARAMETER	WAVEFORM	T _a V	amb = +25° ′ _{CC} = +5.0′	C V	$T_{amb} = -40^{\circ}$ $V_{CC} = +5^{\circ}$	°C to +85°C .0V ±0.5V	UNIT
			Min	Тур	Max	Min	Мах	
t _{PLH} t _{PHL}	Propagation delay An to Yn	1	1.0 3.0	2.8 4.3	4.0 5.8	1.0 3.0	4.9 6.0	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	2	1.5 4.2	3.4 5.5	4.7 7.6	1.5 4.2	5.8 8.4	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.9 2.5	4.1 3.4	5.0 5.8	1.9 2.5	5.6 6.4	ns

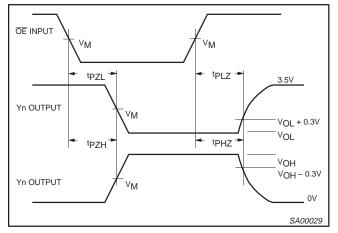
AC WAVEFORMS

 V_{M} = 1.5V, V_{IN} = GND to 3.0V

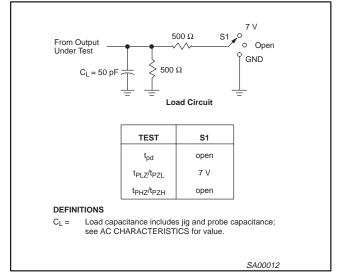


Waveform 1. Waveforms Showing the Input (An) to Output (Yn) Propagation Delays

TEST CIRCUIT AND WAVEFORMS

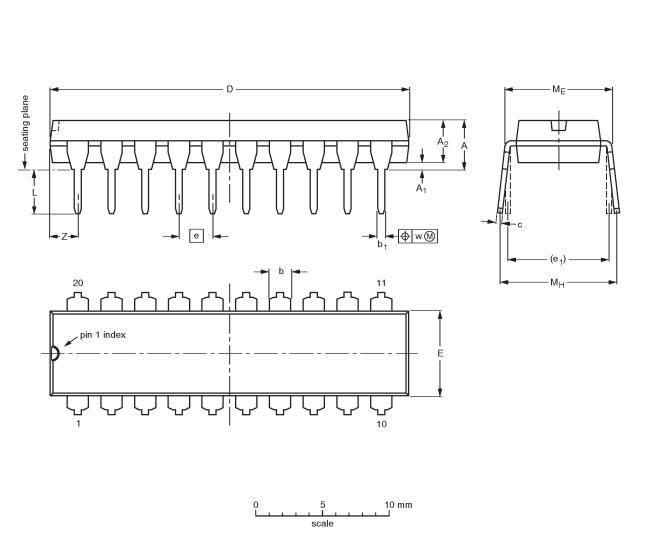


Waveform 2. Waveforms Showing the 3-State Output Enable and Disable Times



74ABT2240

DIP20: plastic dual in-line package; 20 leads (300 mil)



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	c	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	M _E	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES			
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT146-1			SC603		-92-11-17- 95-05-24	

SOT146-1

Product specification

74ABT2240

SO20: plastic small outline package; 20 leads; body width 7.5 mm А = V (M) A Q Ā (Aa) pin 1 index Г Π П 10 detail X \w M е bp 5 10 mm scale DIMENSIONS (inch dimensions are derived from the original mm dimensions) А z⁽¹⁾ D ⁽¹⁾ E⁽¹⁾ A₂ UNIT A_1 A_3 с ${\rm H}_{\rm E}$ L Lp Q v θ bp е w у max. 0.49 0.32 10.65 0.30 2.45 13.0 7.6 1.1 1.1 0.9 2.65 mm 0.25 1.27 0.25 0.25 1.4 0.1 8° 0.10 2.25 0.36 0.23 12.6 7.4 10.00 0.4 1.0 0.4 00 0.30 0.043 0.035 0.012 0.096 0.019 0.013 0.51 0.42 0.043 inches 0.10 0.01 0.050 0.055 0.01 0.004 0.01

Note

0.004

0.089

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

0.014

0.009

0.49

0.29

OUTLINE		REFER	RENCES	EUROPEAN ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ	PROJECTION	1550E DATE	
SOT163-1	075E04	MS-013AC			-92-11-17 95-01-24	

7



0.39

0.016

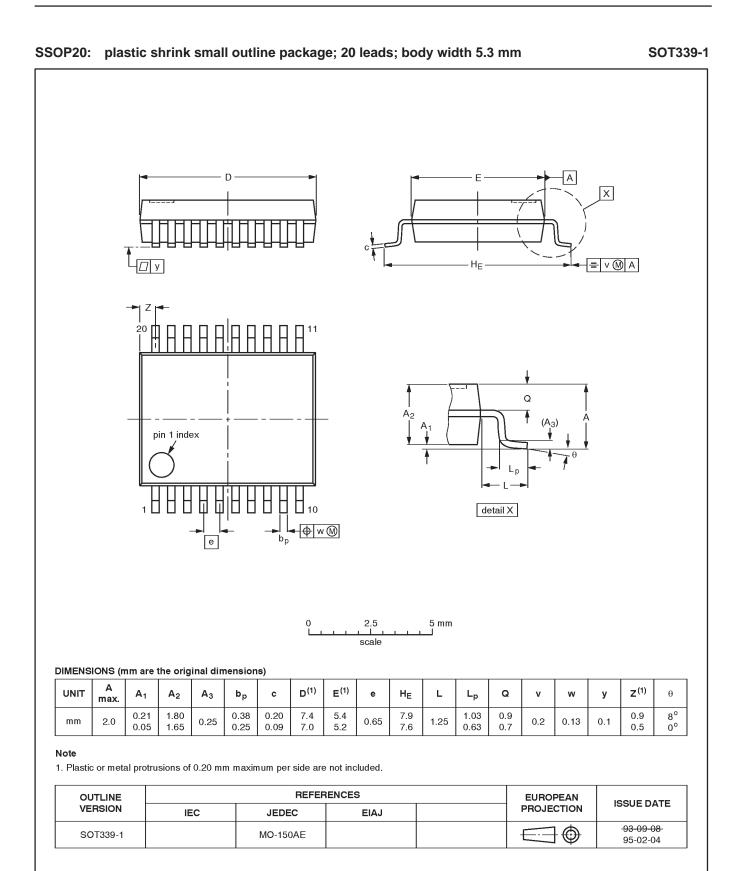
0.039

0.016

SOT163-1

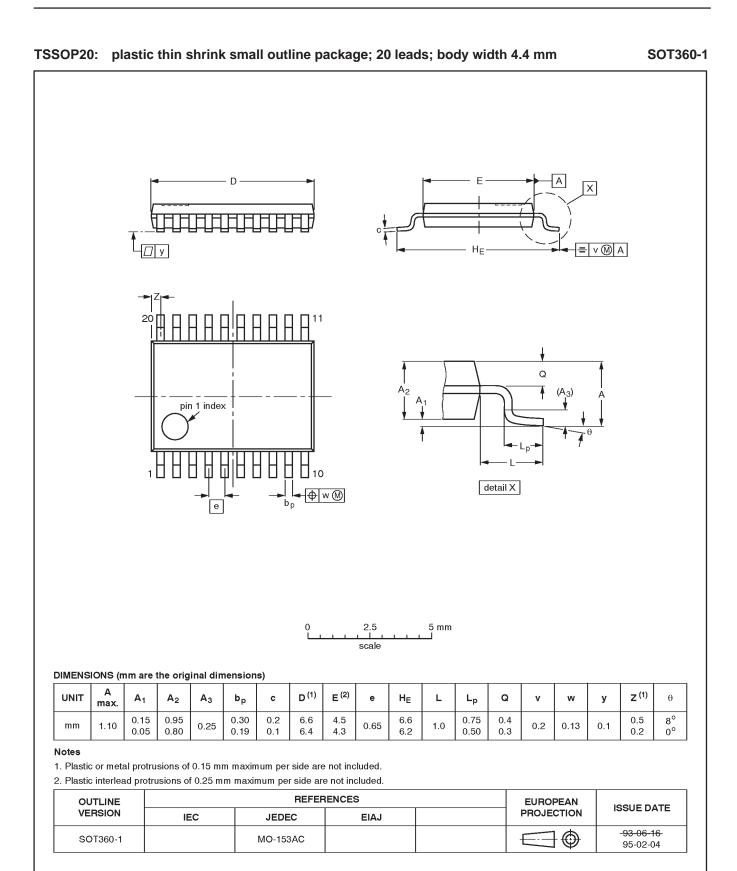
74ABT2240

Product specification



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Product specification



1998 Jan 16

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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